

IGBT Chip in NPT-technology

FEATURES:

- 1200V NPT technology
- 180µm chip
- low turn-off losses
- short tail current
- positive temperature coefficient
- easy paralleling

This chip is used for:

• SGW25N120



Applications:

drives, SMPS, resonant applications

Chip Type	V _{CE}	I _{Cn}	Die Size	Package	Ordering Code
SIGC42T120CS	1200V	25A	6.59 x 6.49 mm ²	sawn on foil	Q67050- A4048-A001

MECHANICAL PARAMETER:

Raster size	6.59 x 6.49				
Emitter pad size	2 x (2.18 x 1.58)	1			
Gate pad size	1.06 x 0.65	1			
Area total / active	42.8 / 33.5				
Thickness	180	μm			
Wafer size	150	mm			
Flat position	180	grd			
Max.possible chips per wafer	334 pcs				
Passivation frontside	Photoimide				
Emitter metallization	3200 nm Al Si 1%				
Collector metallization	1400 nm Ni Ag –system suitable for epoxy and soft solder die bor	nding			
Die bond	electrically conductive glue or solder				
Wire bond	Al, <500μm				
Reject Ink Dot Size	ot Size Ø 0.65mm ; max 1.2mm				
Recommended Storage Environment	store in original container, in dry nitrogen, < 6 month at an ambient temperature of 23°C				



MAXIMUM RATINGS:

Parameter	Symbol	Value	Unit
Collector-emitter voltage, T _j =25 °C	V _{CE}	1200	V
DC collector current, limited by T _{jmax}	I _C	1)	А
Pulsed collector current, t _p limited by T _{jmax}	I _{cpuls}	75	А
Gate emitter voltage	V _{GE}	±20	V
Operating junction and storage temperature	T_j , T_{stg}	-55 + 150	°C

¹⁾ depending on thermal properties of assembly

STATIC CHARACTERISTICS (tested on chip), T_j =25 °C, unless otherwise specified:

Parameter	Symbol	Conditions	Value			Unit
i arameter	Symbol	Conditions	min.	typ.	max.	J.iii
Collector-emitter breakdown voltage	V _{(BR)CES}	V_{GE} =0V , I_{C} = 1.5mA	1200			
Collector-emitter saturation voltage	V _{CE(sat)}	V _{GE} =15V, I _C =25A	2.5	3.0	3.6	V
Gate-emitter threshold voltage	V _{GE(th)}	I _C =1mA , V _{GE} =V _{CE}	3.0	4.0	5.0	
Zero gate voltage collector current	I _{CES}	V _{CE} =1200V , V _{GE} =0V			3	μA
Gate-emitter leakage current	I _{GES}	V _{CE} =0V , V _{GE} =20V			120	nA

ELECTRICAL CHARACTERISTICS (tested at component):

Parameter	Symbol	Conditions	Value			Unit
raiametei	Symbol	Conditions	min.	typ.	max.	Oilit
Input capacitance	Ciss	V _{CE} =25V,	-	2150	2600	pF
Output capacitance	Coss	$V_{GE}=0V$,	-	160	190	
Reverse transfer capacitance	Crss	f=1MHz	-	110	130	

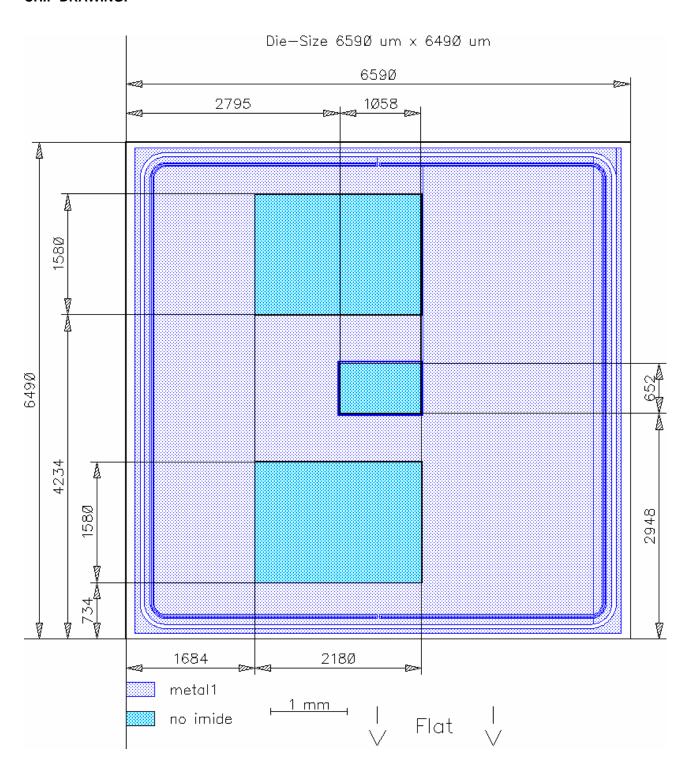
SWITCHING CHARACTERISTICS (tested at component), Inductive Load

Parameter	Symbol Cond	Conditions 1)	Value			Unit
- arameter	Symbol	Conditions	min.	typ.	max.	Oilit
Turn-on delay time	$t_{d(on)}$	<i>T</i> _j = 150 ° C	-	50	60	ns
Rise time	t_{r}	$V_{\rm CC} = 800 \rm V$,	-	36	43	
Turn-off delay time	$t_{d(off)}$	I _C =25A, V _{GE} =-15/15V,	-	820	990	
Fall time	t_{f}	$R_{\rm G}$ = 22 Ω	-	42	50	

¹⁾ values also influenced by parasitic L- and C- in measurement and package.



CHIP DRAWING:





FURTHER ELECTRICAL CHARACTERISTICS:

This chip data sheet refers to the device data sheet	SGW25N120				
DESCRIPTION:					
AQL 0,65 for visual inspection according to failure catalog					
Electrostatic Discharge Sensitive Device according to MIL-STD 883					
Test-Normen Villach/Prüffeld					

Published by Infineon Technologies AG, Bereich Kommunikation St.-Martin-Strasse 53, D-81541 München © Infineon Technologies AG 2002 All Rights Reserved.

Attention please!

The information herein is given to describe certain components and shall not be considered as warranted characteristics.

Terms of delivery and rights to technical change reserved.

We hereby disclaim any and all warranties, including but not limited to warranties of non-infringement, regarding circuits, descriptions and charts stated herein.

Infineon Technologies is an approved CECC manufacturer.

Information

For further information on technology, delivery terms and conditions and prices please contact your nearest Infineon Technologies Office in Germany or our Infineon Technologies Representatives world-wide (see address list).

Warnings

Due to technical requirements components may contain dangerous substances. For information on the types in question please contact your nearest Infineon Technologies Office.

Infineon Technologies components may only be used in life-support devices or systems with the express written approval of Infineon Technologies, if a failure of such components can reasonably be expected to cause the failure of that life-support device or system, or to affect the safety or effectiveness of that device or system. Life support devices or systems are intended to be implanted in the human body, or to support and / or maintain and sustain and / or protect human life. If they fail, it is reasonable to assume that the health of the user or other persons may be endangered.